Search Notes					

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/782,530	MURANAKA ET AL.	
Examiner	Art Unit	
Robert W. Wilson	2619	

SEARCHED				
Class	Subclass	Date	Examiner	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
Refer to	print out	1/2+108	KYN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
·	DATE	EXMR	
Discussed allowability with C: Nguyen	1/24/2008	RWW	
370/389, 470, 474 (Text)	1/24/2008	RWW	
for double patenting	V24108	42	
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